Application/Control No.	Applicant(s)/Patent under Reexamination VAN DER SCHAAR, MIHAELA	
10/056,368		
Examiner	Art Unit	
Annan Q. Shang	2623	

	SEARCHED					
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Class	Subclass	Date	Examiner			
725	87-104	5/11/2007	A.S			
709	217-223	5/11/2007	A.S			

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